



SKiM® 93

## Hybrid SiC Trench IGBT Modules

### SKiM459GD12F4V4

#### Features\*

- IGBT 4 Fast
- SiC Schottky free-wheeling diodes, 6 diodes per switch
- Solderless sinter technology
- $V_{CE(sat)}$  with positive temperature coefficient
- Low inductance case
- Insulated by  $Al_2O_3$  DBC (Direct Bonded Copper) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability
- Integrated temperature sensor
- UL recognized: File no. E63532

#### Typical Applications

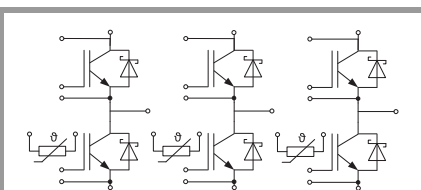
- UPS (inv., rect.)
- Energy storage
- Active front-end

#### Remarks

- Case temperature limited to  $T_s = 125^\circ\text{C}$  max;  $T_c = T_s$  (for baseplateless modules)

#### Footnotes

$I_{FSM}$  value is valid for SiC Schottky diode in combination with IGBT, please see Technical Explanations SKiM63/93 for further details



GD

| Absolute Maximum Ratings |  |                         |                    |      |
|--------------------------|--|-------------------------|--------------------|------|
| Symbol                   | Conditions   |                         | Values             | Unit |
| Inverter - IGBT          |  |                         |                    |      |
| V <sub>CES</sub>         | T <sub>j</sub> = 25 °C   |                         | 1200               | V    |
| I <sub>C</sub>           | λ <sub>paste</sub> =0.8 W/(mK)   | T <sub>s</sub> = 25 °C  | 589                | A    |
|                          | T <sub>j</sub> = 175 °C  | T <sub>s</sub> = 70 °C  | 476                | A    |
| I <sub>C</sub>           | λ <sub>paste</sub> =2.5 W/(mK)   | T <sub>s</sub> = 25 °C  | 687                | A    |
|                          | T <sub>j</sub> = 175 °C  | T <sub>s</sub> = 70 °C  | 558                | A    |
| I <sub>Cnom</sub>        |  |                         | 450                | A    |
| I <sub>CRM</sub>         |  |                         | 1350               | A    |
| V <sub>GES</sub>         |  |                         | -20 ... 20         | V    |
| t <sub>psc</sub>         | V <sub>CC</sub> = 800 V<br>V <sub>GE</sub> ≤ 15 V<br>V <sub>CES</sub> ≤ 1200 V | T <sub>j</sub> = 150 °C | 10                 | μs   |
| T <sub>j</sub>           |  |                         | -40 ... 175        | °C   |
| Inverse - Diode          |  |                         |                    |      |
| V <sub>RRM</sub>         | T <sub>j</sub> = 25 °C   |                         | 1200               | V    |
| I <sub>F</sub>           | λ <sub>paste</sub> =0.8 W/(mK)   | T <sub>s</sub> = 25 °C  | 401                | A    |
|                          | T <sub>j</sub> = 175 °C  | T <sub>s</sub> = 70 °C  | 323                | A    |
| I <sub>F</sub>           | λ <sub>paste</sub> =2.5 W/(mK)   | T <sub>s</sub> = 25 °C  | 455                | A    |
|                          | T <sub>j</sub> = 175 °C  | T <sub>s</sub> = 70 °C  | 367                | A    |
| I <sub>FRM</sub>         |  |                         | 500                | A    |
| I <sub>FSM</sub>         | t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 150 °C                      |                         | 1048 <sup>1)</sup> | A    |
| T <sub>j</sub>           |  |                         | -40 ... 175        | °C   |
| Module                   |  |                         |                    |      |
| I <sub>t(RMS)</sub>      | T <sub>terminal</sub> = 80 °C,   |                         | 700                | A    |
| T <sub>stg</sub>         |  |                         | -40 ... 125        | °C   |
| V <sub>isol</sub>        | AC sinus 50 Hz, t = 1 min  |                         | 2500               | V    |

| Characteristics      |   |                         |      |       |      |      |
|----------------------|---|-------------------------|------|-------|------|------|
| Symbol               | Conditions  |                         | min. | typ.  | max. | Unit |
| Inverter - IGBT      |   |                         |      |       |      |      |
| V <sub>CE(sat)</sub> | I <sub>C</sub> = 450 A  | T <sub>j</sub> = 25 °C  |      | 2.05  | 2.42 | V    |
|                      | V <sub>GE</sub> = 15 V<br>chipelevel                                    | T <sub>j</sub> = 150 °C |      | 2.59  | 2.96 | V    |
| V <sub>CE0</sub>     | chipelevel  | T <sub>j</sub> = 25 °C  |      | 1.10  | 1.28 | V    |
|                      |   | T <sub>j</sub> = 150 °C |      | 0.95  | 1.13 | V    |
| r <sub>CE</sub>      | V <sub>GE</sub> = 15 V<br>chipelevel                                    | T <sub>j</sub> = 25 °C  |      | 2.1   | 2.5  | mΩ   |
|                      |   | T <sub>j</sub> = 150 °C |      | 3.6   | 4.1  | mΩ   |
| V <sub>GE(th)</sub>  | V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 15.6 mA            |                         | 5.2  | 5.8   | 6.4  | V    |
| I <sub>CES</sub>     | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V, T <sub>j</sub> = 25 °C |                         |      |       | 6    | mA   |
| C <sub>ies</sub>     | V <sub>CE</sub> = 25 V<br>V <sub>GE</sub> = 0 V                         | f = 1 MHz               |      | 26.4  |      | nF   |
| C <sub>oes</sub>     |   | f = 1 MHz               |      | 1.74  |      | nF   |
| C <sub>res</sub>     |   | f = 1 MHz               |      | 1.41  |      | nF   |
| Q <sub>G</sub>       | V <sub>GE</sub> = - 8 V...+ 15 V  |                         |      | 2550  |      | nC   |
| R <sub>Gint</sub>    | T <sub>j</sub> = 25 °C  |                         |      | 1.7   |      | Ω    |
| t <sub>d(on)</sub>   | V <sub>CC</sub> = 600 V   | T <sub>j</sub> = 150 °C |      | 258   |      | ns   |
| t <sub>r</sub>       | I <sub>C</sub> = 250 A  |                         |      | 30    |      | ns   |
| E <sub>on</sub>      | R <sub>G on</sub> = 1.2 Ω   | T <sub>j</sub> = 150 °C |      | 5     |      | mJ   |
| t <sub>d(off)</sub>  | R <sub>G off</sub> = 1.2 Ω  | T <sub>j</sub> = 150 °C |      | 517   |      | ns   |
| t <sub>f</sub>       | di/dt <sub>on</sub> = 8060 A/μs   | T <sub>j</sub> = 150 °C |      | 73    |      | ns   |
| E <sub>off</sub>     | di/dt <sub>off</sub> = 3520 A/μs  | T <sub>j</sub> = 150 °C |      |       |      |      |
|                      | dv/dt = 3430 V/μs   |                         |      |       |      |      |
| E <sub>off</sub>     | V <sub>GE</sub> = +15/-15 V   | T <sub>j</sub> = 150 °C |      | 20    |      | mJ   |
|                      | L <sub>s</sub> = 30 nH  |                         |      |       |      |      |
| R <sub>th(j-s)</sub> | per IGBT, λ <sub>paste</sub> =0.8 W/(mK)                                |                         |      | 0.069 |      | K/W  |
| R <sub>th(j-s)</sub> | per IGBT, λ <sub>paste</sub> =2.5 W/(mK)                                |                         |      | 0.053 |      | K/W  |



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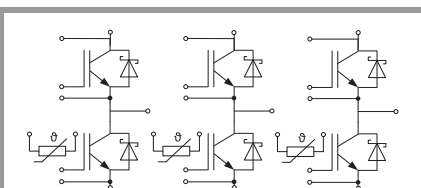
#### Remarks

- Case temperature limited to  $T_s = 125^\circ\text{C}$  max;  $T_c = T_s$  (for baseplateless modules)

#### Footnotes

$I_{FSM}$  value is valid for SiC Schottky diode in combination with IGBT, please see Technical Explanations SKiM63/93 for further details

| Characteristics                  |   |                         |      |           |      |      |
|----------------------------------|---|-------------------------|------|-----------|------|------|
| Symbol                           | Conditions  |                         | min. | typ.      | max. | Unit |
| Inverse - Diode                  |   |                         |      |           |      |      |
| V <sub>F</sub> = V <sub>EC</sub> | I <sub>F</sub> = 250 A  | T <sub>j</sub> = 25 °C  |      | 1.33      | 1.51 | V    |
|                                  | chiplevel   | T <sub>j</sub> = 150 °C |      | 1.63      | 1.90 | V    |
| V <sub>F0</sub>                  | chiplevel   | T <sub>j</sub> = 25 °C  |      | 0.95      | 1.05 | V    |
|                                  |   | T <sub>j</sub> = 150 °C |      | 0.80      | 0.90 | V    |
| r <sub>F</sub>                   | chiplevel   | T <sub>j</sub> = 25 °C  |      | 1.50      | 1.83 | mΩ   |
|                                  |   | T <sub>j</sub> = 150 °C |      | 3.3       | 4.0  | mΩ   |
| C <sub>j</sub>                   | V <sub>R</sub> = 800 V, f = 1 MHz, T <sub>j</sub> = 25 °C   |                         |      | 1.260     |      | nF   |
| Q <sub>c</sub>                   | V <sub>R</sub> = 800 V, di/dt <sub>off</sub> = 500 A/μs, T <sub>j</sub> = 25 °C   |                         |      | 1         |      | μC   |
| R <sub>th(j-s)</sub>             | per Diode, λ <sub>paste</sub> =0.8 W/(mK)   |                         |      | 0.142     |      | K/W  |
| R <sub>th(j-s)</sub>             | per Diode, λ <sub>paste</sub> =2.5 W/(mK)   |                         |      | 0.115     |      | K/W  |
| Module                           |   |                         |      |           |      |      |
| L <sub>CE</sub>                  |   |                         |      | 10        | 15   | nH   |
| R <sub>CC'+EE'</sub>             | measured per switch   | T <sub>s</sub> = 25 °C  |      | 0.3       |      | mΩ   |
|                                  |   | T <sub>s</sub> = 125 °C |      | 0.5       |      | mΩ   |
| w                                |   |                         |      | 1042      |      | g    |
| Temperature Sensor               |   |                         |      |           |      |      |
| R <sub>100</sub>                 | T <sub>r</sub> =100°C (R <sub>25</sub> =1000Ω)  |                         |      | 1670 ± 1% |      | Ω    |
| R <sub>(T)</sub>                 | R(T)=1kΩ[1+A(T-25°C)+B(T-25°C) <sup>2</sup> ],<br>A = 7.64*10 <sup>-3</sup> °C <sup>-1</sup> , B = 1.73*10 <sup>-5</sup> °C <sup>-2</sup> |                         |      |           |      |      |



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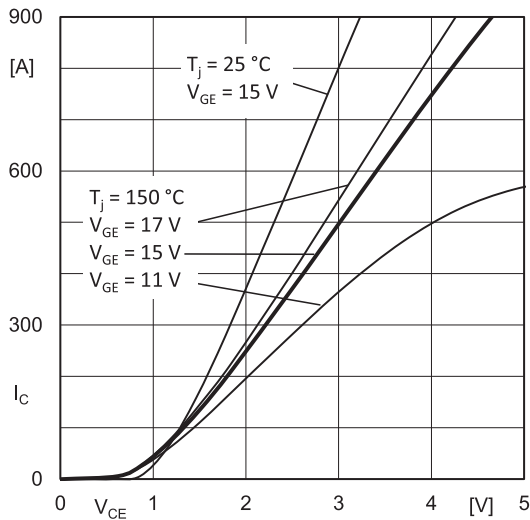


Fig. 1: Typ. output characteristic, inclusive  $R_{CC}'+EE'$

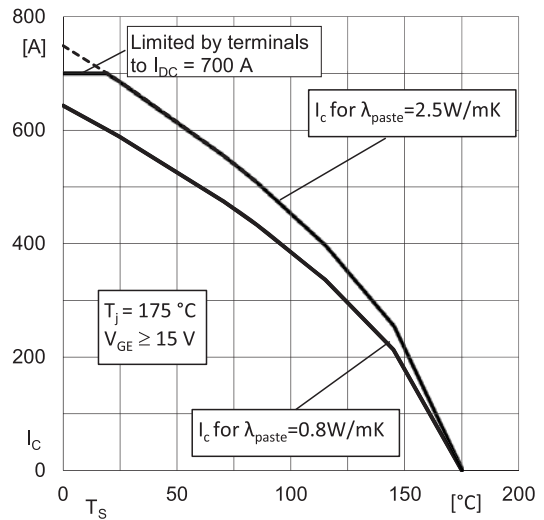


Fig. 2: Typ. rated current vs. temperature  $I_C = f(T_s)$

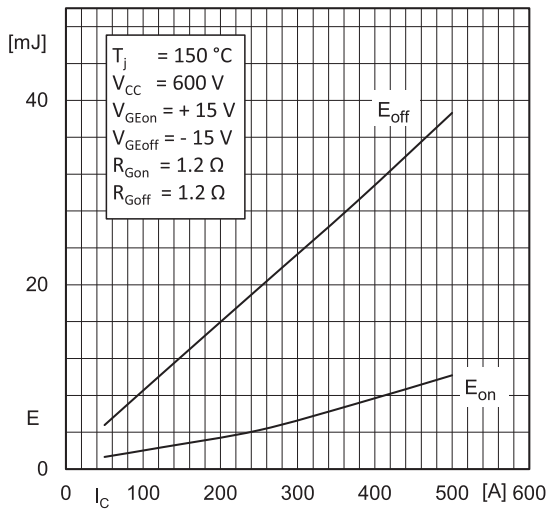


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

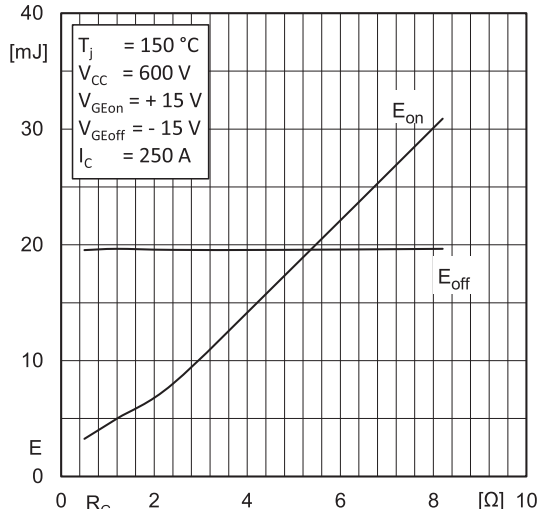


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

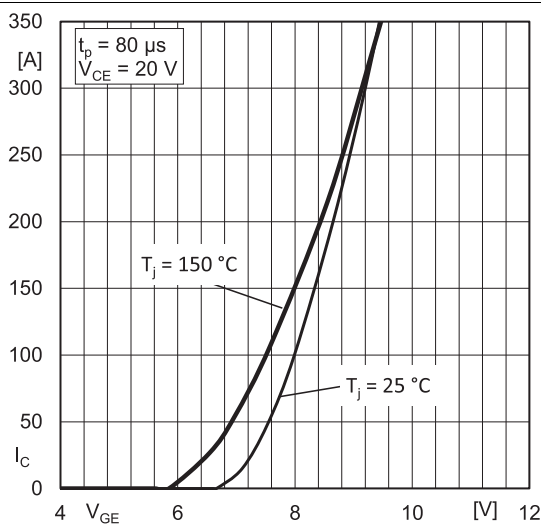


Fig. 5: Typ. transfer characteristic

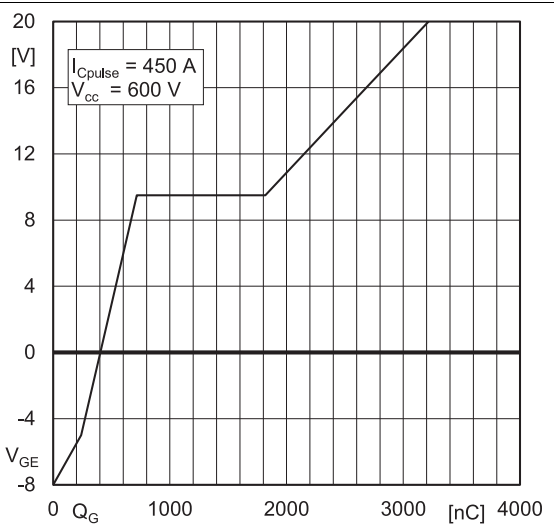


Fig. 6: Typ. gate charge characteristic

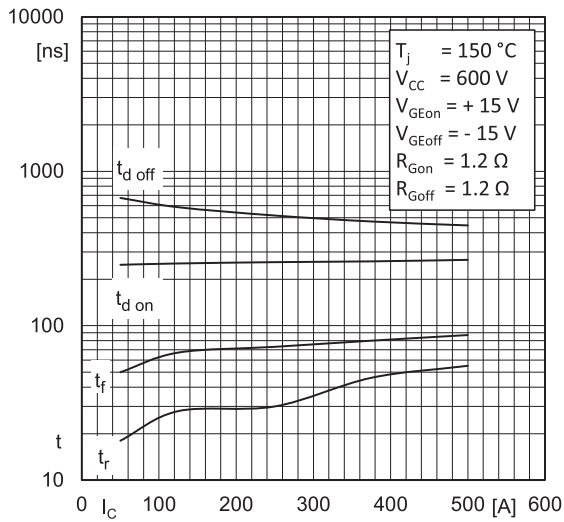


Fig. 7: Typ. switching times vs.  $I_C$

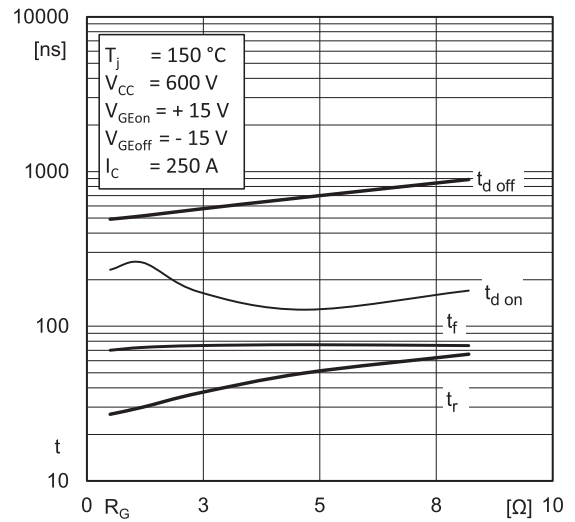


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

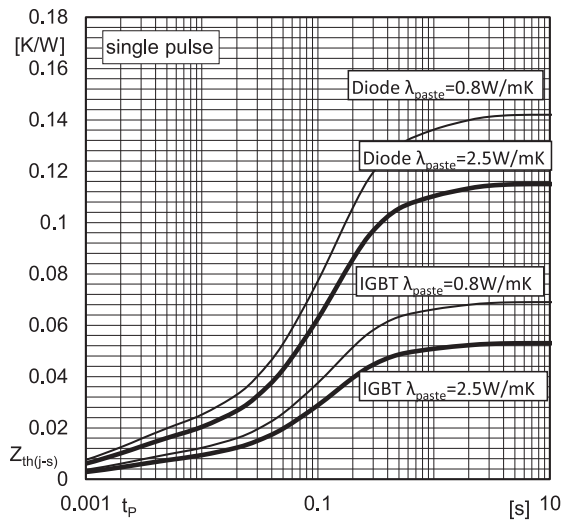


Fig. 9: Typ. transient thermal impedance

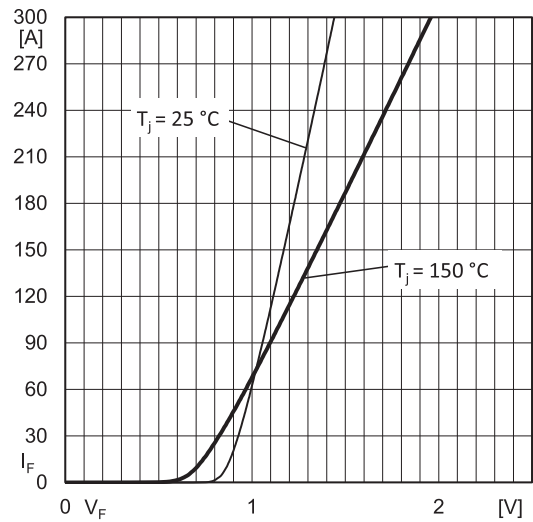


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC'+EE'}$

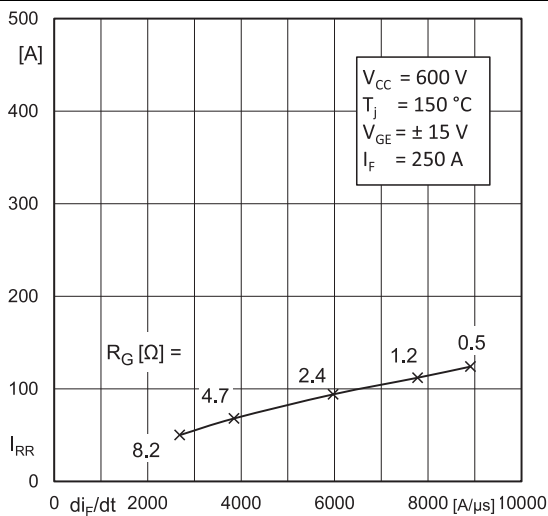
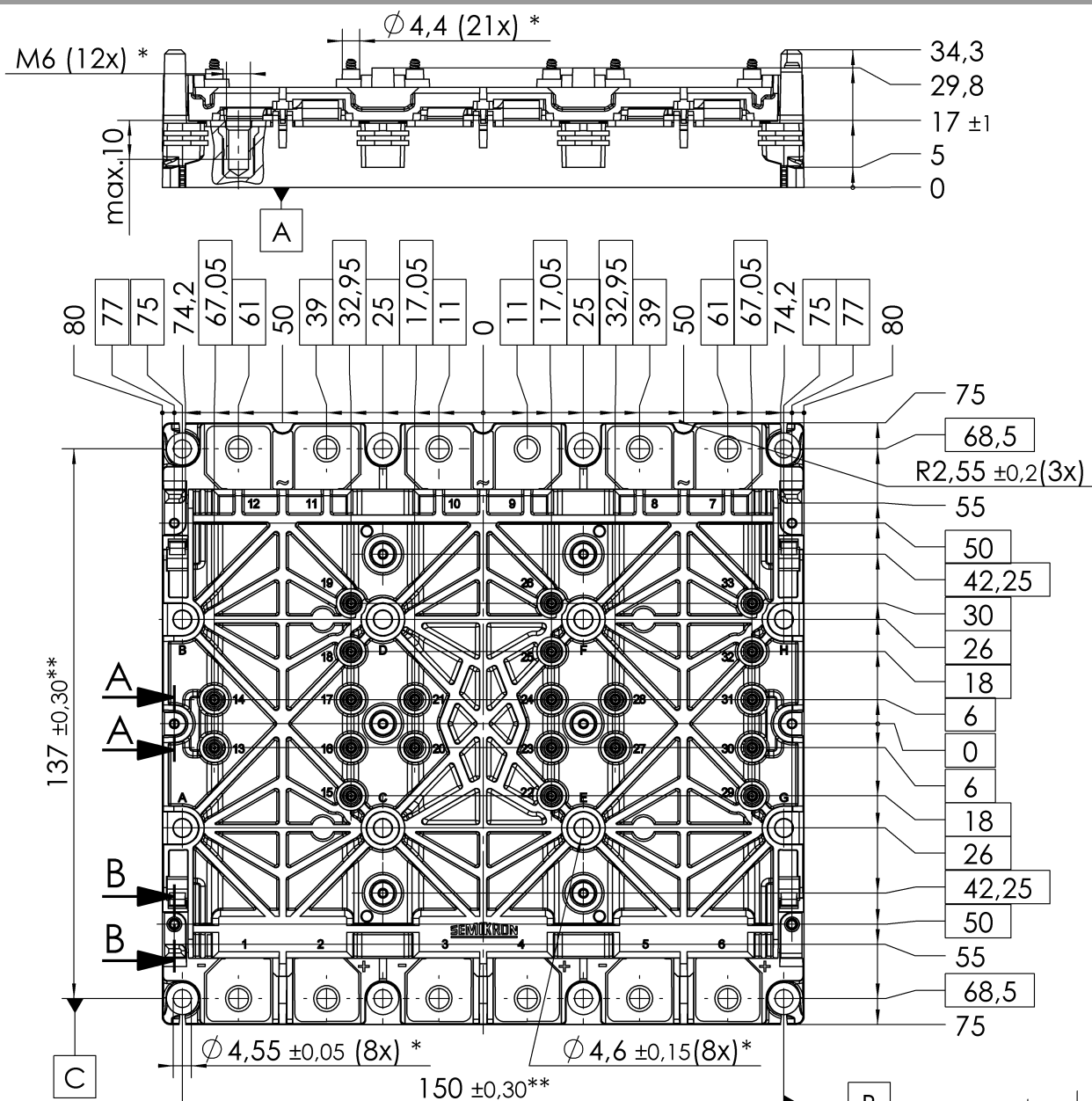


Fig. 11: Typ. CAL diode peak reverse recovery current

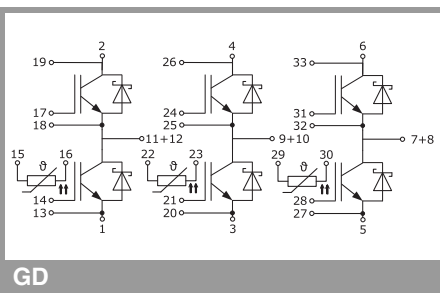


\* all pos. dimensions valid when mounted

| $\phi$ | $\phi 0,9$ | A | B | C |
|--------|------------|---|---|---|
|--------|------------|---|---|---|

\*\* valid for the outer 4 inserts

General Tolerances DIN ISO 2768-m  
PCB spring landing pad =  $\phi 3,5 \pm 0,2$



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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